

IGBT3 Chip Medium Power

Features:

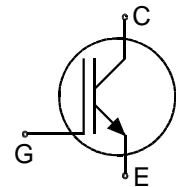
- 650V Trench & Field Stop technology
- high short circuit capability, self limiting short circuit current
- positive temperature coefficient
- easy paralleling
- Qualified according to JEDEC for target applications

Recommended for:

- power modules

Applications:

- drives



Chip Type	V _{CE}	I _{CN}	Die Size	Package
IGC76T65T8RM	650V	150A	7.87 x 9.69 mm ²	sawn on foil

Mechanical Parameters

Die size		7.87 x 9.69	mm ²
Emitter pad size (incl. gate pad)		See chip drawing	
Gate pad size		1.615 x 0.817	
Area total		76.3	
Thickness		80	µm
Wafer size		200	mm
Max.possible chips per wafer		335	
Passivation frontside		Photoimide	
Pad metal		3200 nm AlSiCu	
Backside metal		Ni Ag –system	
Die bond		Electrically conductive epoxy glue and soft solder	
Wire bond		Al, <500µm	
Reject ink dot size		Ø 0.65mm ; max 1.2mm	
Storage environment	for original and sealed MBB bags	Ambient atmosphere air, Temperature 17°C – 25°C, < 6 month	
	for open MBB bags	Acc. to IEC62258-3: Atmosphere >99% Nitrogen or inert gas, Humidity <25%RH, Temperature 17°C – 25°C, < 6 month	

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-Emitter voltage, $T_{vj}=25\text{ °C}$	V_{CE}	650	V
DC collector current, limited by $T_{vj\text{ max}}$	I_C	1)	A
Pulsed collector current, t_p limited by $T_{vj\text{ max}}$ 2)	$I_{C,puls}$	450	A
Gate emitter voltage	V_{GE}	± 20	V
Operating junction temperature	T_{vj}	-40 ... +175	°C
Short circuit data 2)3) $V_{GE} = 15V, V_{CC} = 360V, T_{vj} = 150\text{ °C}$	t_{SC}	10	μs

1) depending on thermal properties of assembly

2) not subject to production test - verified by design/characterization

3) allowed number of short circuits: <1000; time between short circuits: >1s.

Static Characteristics (tested on wafer), $T_{vj}=25\text{ °C}$

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-Emitter breakdown voltage	$V_{(BR)CES}$	$V_{GE}=0V, I_C=4\text{ mA}$	650			V
Collector-Emitter saturation voltage	V_{CEsat}	$V_{GE}=15V, I_C=45A$	0.89	1.06	1.23	
Gate-Emitter threshold voltage	$V_{GE(th)}$	$I_C=2.4mA, V_{GE}=V_{CE}$	5.1	5.8	6.4	
Zero gate voltage collector current	I_{CES}	$V_{CE}=650V, V_{GE}=0V$			0.76	μA
Gate-Emitter leakage current	I_{GES}	$V_{CE}=0V, V_{GE}=20V$			600	nA
Integrated gate resistor	r_G			2		Ω

Electrical Characteristics (not subject to production test - verified by design / characterization)

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-Emitter saturation voltage	V_{CEsat}	$V_{GE}=15V, I_C=150A$		1.55	1.95	V
			$T_{vj}=25\text{ °C}$		1.75	
Input capacitance	C_{ies}	$V_{CE}=25V, V_{GE}=0V, f=1MHz, T_{vj}=25\text{ °C}$		9240		pF
Reverse transfer capacitance	C_{res}			274		



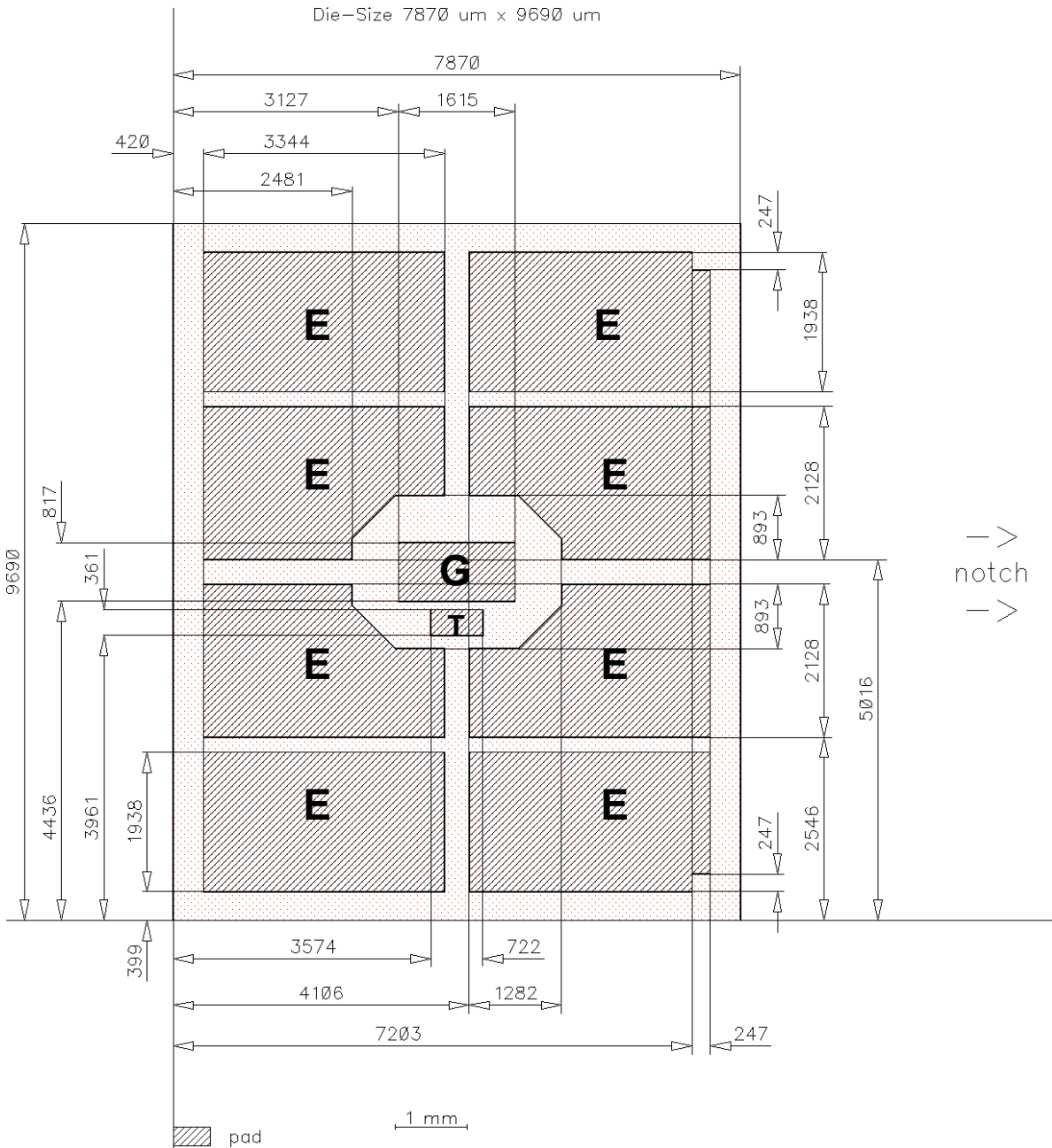
IGC76T65T8RM

Further Electrical Characteristic

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

This chip data sheet refers to the device data sheet	FS150R07N3E4	Rev 2.0
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Chip Drawing



E = Emitter
G = Gate
T = Test pad do not contact



IGC76T65T8RM

Description

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Revision History

Version	Subjects (major changes since last revision)	Date

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